

Application/Control No.	Applicant(s)/Patent under Reexamination
10/808,257	SVENDSEN ET AL.
Examiner	Art Unit

3751

David J. Walczak

SEARCHED				
Class	Subclass	Date	Examiner	
401	9, 10, 137- 140	5/16/2005	DW	
15	114, 115,			
	116.1,	-		
	116.2,			
	160,			
	DIG 5			
		**** =		
			-	

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
		,			

(INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
		-	
		•	
		 	
		ļ	
		ŀ	